

Notice of References Cited	Application/Control No. 10/598,025		Applicant(s)/Patent Under Reexamination DE HAAN ET AL.	
	Examiner KENNETH CHANG		Art Unit 2438	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0174837 A1	09-2003	Candelore et al.	380/210
*	C	US-2004/0109671 A1	06-2004	Kuno et al.	386/068
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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